

**Notice of References Cited**

Application/Control No.

09/993,619

Applicant(s)/Patent Under  
Reexamination  
ABE ET AL.

Examiner

German Colón

Art Unit

2879

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,601,731	08-1971	Christiana et al.	335/300
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 572192 A1	12-1993	European Patent	IKEUCHI, HIROSHI	H01J 09/236
	O	JP 06168677 A	06-1994	Japan	MURATA, AKIO	H01J 29/76
	P	JP 01151134 A	06-1989	Japan	HIROTA et al.	H01J 29/76
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.